## Notice of References Cited Application/Control No. 09/367,433 Examiner Jean W. Désir Applicant(s)/Patent Under Reexamination ELEFTHERIADIS ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,822,460 A	10-1998	Kim, Jong-II	382/243
*	В	US-6,026,195 A	02-2000	Eifrig et al.	382/236
*	С	US-6,037,988 A	03-2000	Gu et al.	375/240.16
*	D	US-6,069,669 A	05-2000	Park et al.	348/596
*	Е	US-6,079,566 A	06-2000	Eleftheriadis et al.	707/101
*	F	US-6,092,107 A	07-2000	Eleftheriadis et al.	709/217
*	G	US-6,339,618 B1	01-2002	Puri et al.	375/240.16
*	Η	US-6,414,678 B1	07-2002	Goddard et al.	345/419
*	1	US-6,526,177 B1	02-2003	Haskell et al.	382/243
*	7	US-6,549,659 B1	04-2003	Welch et al.	382/203
*	К	US-6,621,932 B2	09-2003	Hagai et al.	382/233
*	L	US-6,621,939 B1	09-2003	Negishi et al.	382/291
*	Μ	US-7,095,450 B1	08-2006	Holmes et al.	348/586

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	•				
	0					
	Р					
	Q					
	R			•		
	s					
L	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	×	•				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.